# Notice of References Cited

Application/Control No.

O9/841,373

Examiner

Nihir Patel

Applicant(s)/Patent Under
Reexamination
LOW ET AL.

Art Unit
Page 1 of 3

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-5,372,183	12-1994	Strickberger, Harold P.	165/41
	В	US-5,351,747	10-1994	Koeppl, Alois	165/41
	С	US-5,351,746	10-1994	Mackey et al.	165/41
	D	US-5,289,871	03-1994	Leidinger, Bernhard	165/110
	E	US-5,101,884	04-1992	Leidinger, Berhard	165/41
	F	US-5,027,892	07-1991	Bannon et al.	165/41
	G	US-4,830,097	05-1989	Tanzer, Herbert J.	165/41
	Н	US-4,815,525	03-1989	Readman, John	165/41
	ı	US-4,813,476	03-1989	Mahefkey, Edward T.	165/272
	J	US-3,756,493	09-1973	Holmes, Gordon W.	229/5.5
	К	US-4,738,304	04-1988	Chalmers et al.	165/281
	L	US-4,727,932	03-1988	Mahefkey, Edward T.	165/41
	М	US-4,706,740	11-1987	Mahefkey, Edward T.	165/104.14

# FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
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# NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	х	(C., MDED S 707.05(a).)

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited Application/Control No. O9/841,373 Examiner Nihir Patel Applicant(s)/Patent Under Reexamination LOW ET AL. Art Unit Page 2 of 3

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	А	US-4,603,732	08-1986	Niggemann, Richard E.	165/41
	В	US-6,591,899	07-2003	Yee, Eddy M.	165/104.26
	С	US-5,069,274	12-1991	Haslett et al.	165/272
	D	US-5,267,605	12-1993	Doty et al.	165/41
	E	US-5,036,905	08-1991	Eninger et al.	165/41
	F	US-6,669,147	12-2003	Bertheux et al.	244/158R
	G	US-6,478,258	11-2002	Yee, Eddy M.	244/163
	Н	US-6,439,297	08-2002	Dunbar et al.	165/46
		US-6,230,790	05-2001	Hemingway et al.	165/80.4
<u></u>	J	US-6,220,548	04-2001	Hyman, Nelson L.	244/158R
	к	US-6,173,923	01-2001	Penera et al.	244/173
	L	US-6,102,339	08-2000	Wu et al.	244/173
	М	US-6,098,931	08-2000	Bard, Max	244/173

# FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
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# NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited Application/Control No. 09/841,373 Examiner Nihir Patel Applicant(s)/Patent Under Reexamination LOW ET AL. Page 3 of 3

#### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,080,962	06-2000	Lee, David W. Y.	219/209
	В	US-6,073,887	06-2000	Hosick, Daryl K.	244/158R
	С	US-5,957,408	09-1999	Hall et al.	244/158R
	D	US-5,954,298	09-1999	Basuthakur et al.	244/163
	E	US-5,823,477	10-1998	York, Gary M.	244/163
<u> </u>	F	US-5,806,803	09-1998	Watts, Keith P.	244/163
	G	US-5,806,800	09-1998	Caplin, Glenn N.	244/158R
_	Н	US-5,794,890	08-1998	Jones et al.	244/163
	<del> </del>	US-5,787,969	08-1998	Drolen et al.	165/41
	J	US-5,743,325	04-1998	Esposto, David B.	165/41
	К	US-5,735,489	04-1998	Drolen et al.	244/163
	L	US-5,494,241	02-1996	Poulain, Bertrand	244/163
	М	US-			

# FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
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# NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.